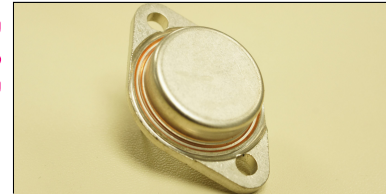


HIGH POWER NPN

GSRU20030
 GSRU20035
 GSRU20040



The GSRU series of NPN silicon transistors is designed for high speed switching systems.

This unique series features manufacturing process which provides surface stabilization for high voltage operation and enhances long term reliability.

NPN
300, 350, 400V
20 AMP SWITCHING
t₁ -100ns TYPICAL

TO-204AA (TO-3)

- High Speed
- Rugged
- Cost Effective
- Offline Power Supplies
- Switching Amplifiers
- Inverters/Converters
- Motor Speed Control Circuits
- Switching Regulators
- Solenoid & Relay Drivers

MAXIMUM RATINGS (T_c=25° C unless otherwise noted)

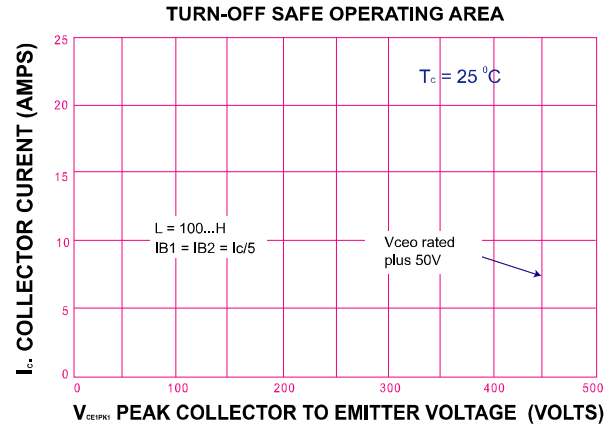
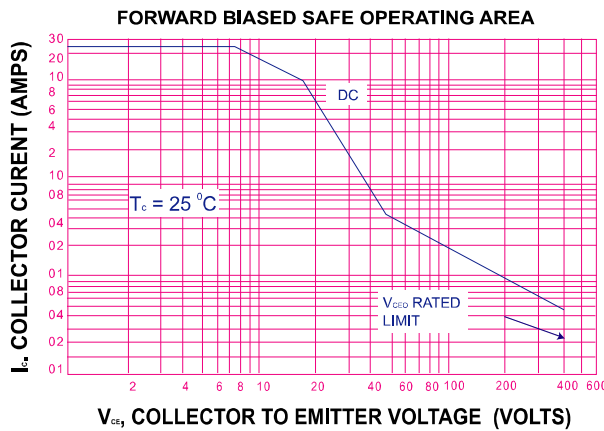
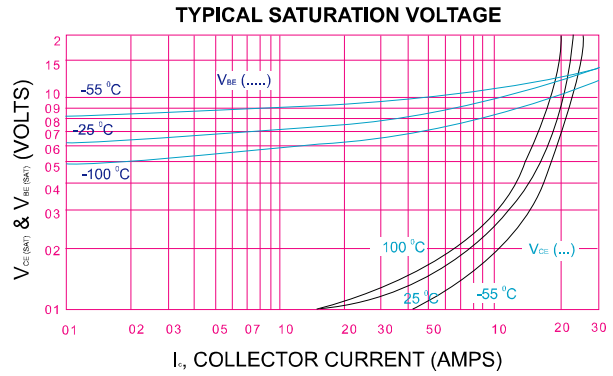
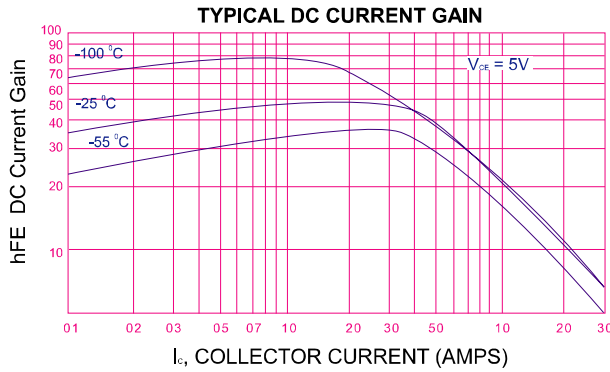
RATING	SYMBOL	GSRU20030	GSRU20035	GSRU20040	UNIT
Collector-Base Voltage	V _{CB0}	400	450	500	Volts
Collector-Emitter Voltage	V _{CE0}	300	350	400	Volts
Emitter-Base Voltage	V _{EB0}	8.0	8.0	8.0	Volts
Collector Current-Continuous	I _c	25	25	25	Amps
Peak	I _{GM}	30	30	30	Amps
Base Current-Continuous	I _b	10	10	10	Amps
Total Power Dissipation @ T _c =25° C	P _D	200	200	200	Watts
O _{J-C1} Junction to Case Thermal Resistance	R _{θJC}	.875	.875	.875	°C/W
Operating and Storage Junction Temp Range	T _{LOPER} T _{STG}	-65 to +200	-65 to +200	-65 to +200	°C

ELECTRICAL CHARACTERISTICS (T_c = 25° C unless otherwise noted)

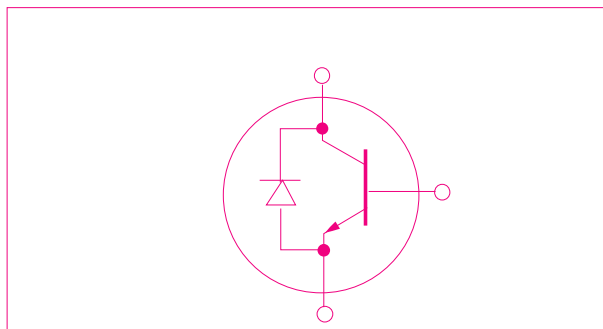
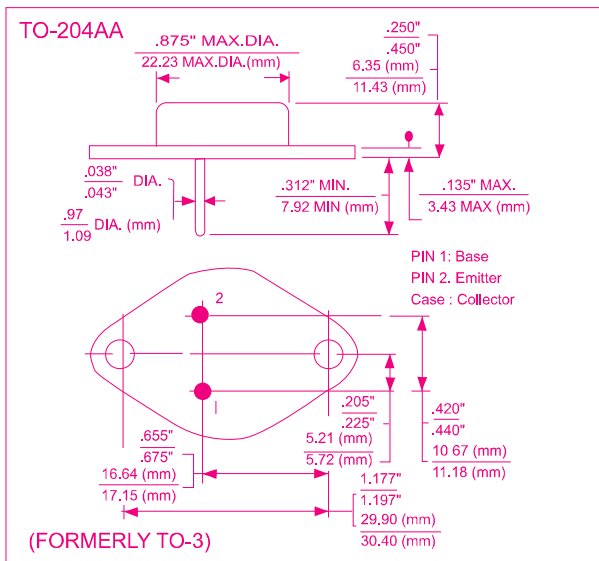
SYMBOL	CONDITIONS	GSRU20030		GSRU20035		GSRU20040		Unit
		Min	Max	Min	Max	Min	Max	
V _{CB0}	I _c = 1.0mA	400	-	450	-	500	-	Volts
V _{CE0}	I _D = 50mA	300	-	350	-	400	-	Volts
V _{EB0}	I _E = 1.0mA	8.0	-	8.0	-	8.0	-	Volts
I _{CB0}	V _{CB} = 80% of Rated V _{CB0}	-	100	-	100	-	100	μA
I _{EB0}	V _{EB} = 5.0V	-	10	-	10	-	10	μA
H _{FET}	V _{CE} = 5.0V, I _c = 20A	8.0	-	8.0	-	8.0	-	-
V _{CE(SA) t}	I _c = 20A, I _b = 4.0A	-	1.5	-1.5	-	1.5	-	Volts
V _{BE(SA) t}	I _c = 20A, I _b = 4.0A	-	1.6	-	1.6	-	1.6	Volts
F	V _{CE} = 10V, I _c = 1.0A, f = 10MHZ	10	-	20	-	20	-	MHZ
C _{OB0}	V _{CB} = 10V, f = 1.0MHZ	-	500	-	500	-	500	pF
SWITCHING		Typ	Max	Typ	Max	Typ	Max	Unit
t _d	Resistive Load V _{CC} = 250V I _c = 20A, R = 12.5 Ω I _{b1} = I _{b2} = 4.0A t _p = 50 μSec	0.025	0.07	0.05	0.07	0.05	0.07	μs
t _i		0.25	0.50	0.25	0.50	0.25	0.50	μs
t _s		2.00	2.50	2.00	2.50	2.00	2.50	μs
t _f		0.10	0.20	0.10	0.20	0.10	0.20	μs
t _s	Inductive Load V _{CLAMP} = 250V I _c = 20A, L = 100 μH I _{b1} = I _{b2} = 4.0A t _p = 50 μsec	1.70	2.40	1.70	2.40	1.70	2.40	μs
t _v		0.20	0.35	0.20	0.35	0.20	0.35	μs
t _n		0.07	0.12	0.07	0.12	0.08	0.12	μs
t _c		0.30	0.50	0.30	0.50	0.30	0.50	μs
t _s 100 °C		2.00	3.00	2.00	3.00	2.00	3.00	μs
t _v 100 °C		0.25	0.40	0.25	0.40	0.25	0.40	μs
t _s 100 °C		0.10	0.20	0.10	0.20	0.10	0.20	μs
t _c 100 °C		0.40	0.70	0.40	0.70	0.40	0.70	μs

t pulse conditions: width=300μs; duty cycl<=2% (measured using kelvin connections).





PACKAGE OUTLINE



Note:
 The technology utilized to produce these devices results in an internal diode between the collector and emitter. In some cases this may eliminate the need for an external diode to clamp inductive loads. At 20 A, $t_r = 600$ ns and $V_f = 1.25V$ (typical).

